

Femtosecond dynamics of exciton and structure in 2H-MoTe₂

Ji-Hee Kim and Young Hee Lee

Center for Integrated Nanostructure Physics, Institute for Basic Science (IBS), Sungkyunkwan University, Suwon 16419, South Korea
kimj@skku.edu, leeyoung@skku.edu

Van der Waals (vdW) layered materials have great potential for optoelectronic devices, such as photodetectors, photovoltaics with efficient power conversion, and high-speed memory/switching devices [1-3]. Reduced dimensionality in the vdW layered materials provides strong Coulomb interaction with a large exciton binding energy of about 0.3~1 eV in a monolayer although these values are scaled down to less than 0.1 eV by charge screening in thin film. Here, we will discuss the photoexcited excitons and structure dynamics of 2H-MoTe₂ by using femtosecond pump-probe spectroscopy. When photoexcited charge carrier density in the vdW layered material is sufficiently low, exciton-exciton scattering prevails over exciton-phonon scattering which makes efficient carrier multiplication phenomena more competitive with other relaxation pathways due to the strong Coulomb coupling (Fig. 1a) [4]. When the carrier density is over 10¹⁴ cm⁻² per monolayer, the structural deformation from semiconducting to metallic phases occurs (Fig. 1b). This phase transition is fully reversible within a picosecond via light control.

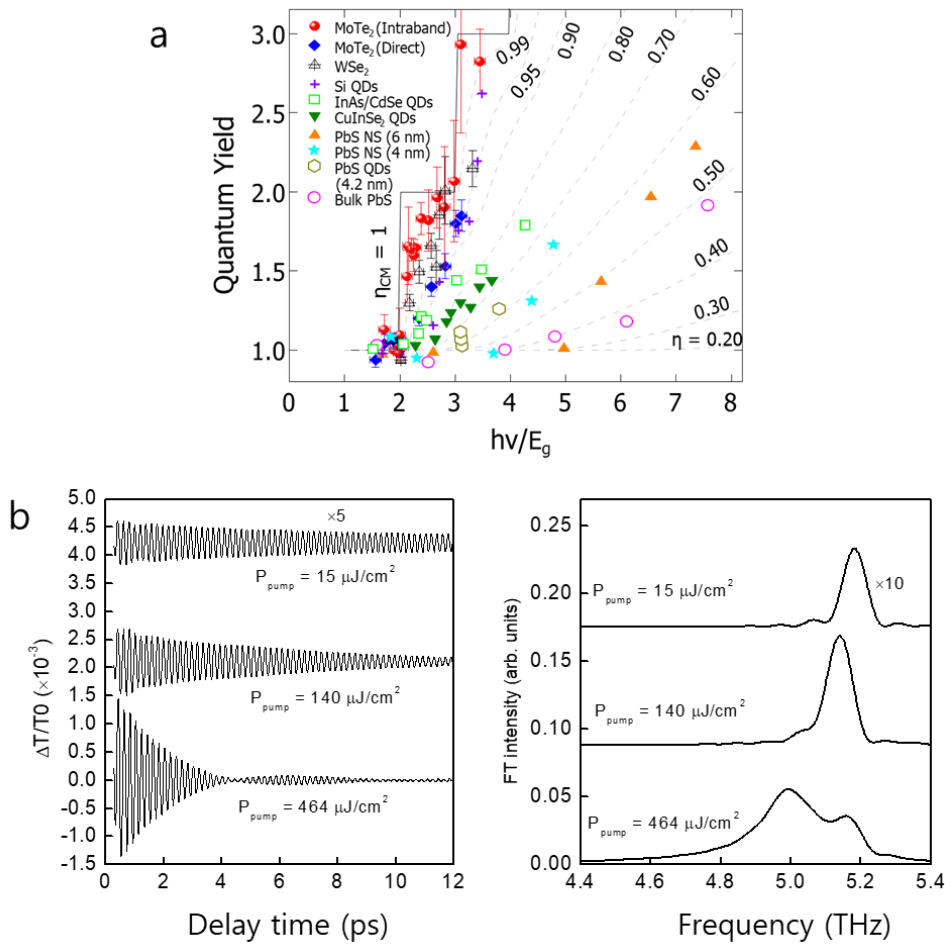


Fig. 1. (a) Carrier multiplication conversion efficiency in various nanostructure including 2H-MoTe₂. (b) Coherent phonon oscillations and Fourier transformation spectra with different pump fluence.

- [1] Dung-Sheng Tsai, Keng-Ku Liu, Der-Hsien Lien, Meng-Lin Tsai, Chen-Fang Kang, Chin-An Lin, Lain-Jong Li, and Jr-Hau He, ACS Nano 7, 3905 (2013).
 [2] He Tian, Bingchen Deng, Matthew L. Chin, Xiaodong Yan, Hao Jiang, Shu-Jen Han, Vivian Sun, Qiangfei Xia, Madan Dubey, Fengnian Xia, and Han Wang, ACS Nano 10, 10428 (2016).
 [3] Meng-Lin Tsai, Sheng-Han Su, Jan-Kai Chang, Dung-Sheng Tsai, Chang-Hsiao Chen, Chih-I Wu, Lain-Jong Li, Lih-Juann Chen, and Jr-Hau He, ACS Nano 8, 8317 (2014).
 [4] Ji-Hee Kim, Matthew R. Bergren, Jin Cheol Park, Subash Adhikari, Michael Lorke, Thomas Fraunheim, Duk-Hyun Choe, Beom Kim, Hyunyoung Choi, Tom Gregorkiewicz, and Young Hee Lee, arXiv:1801.01675.